

<b>Search Notes</b>  <b>*1056826</b>  <b>4*</b>	<b>Application/Control No.</b>  10568264	<b>Applicant(s)/Patent Under Reexamination</b>  LIEW ET AL.
	<b>Examiner</b>  JERRY LIN	<b>Art Unit</b>  1631

SEARCHED			
Class	Subclass	Date	Examiner
702	19	12/13/2010	JL

SEARCH NOTES		
Search Notes	Date	Examiner
West, Google Scholar: HSPCA, IKBKAP, IL13RA1, LAMC1, MAFB, PF4	5/7/2010	JL
Inventor Search: liew, yager, dempsey, chao in palm	12/13/2010	JL
See Printout	12/13/2010	JL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	19	12/13/2010	JL

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